

<b>Notice of References Cited</b>	Application/Control No. 10/804,815		Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner PATRICK A. DARNO		Art Unit 2158	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,555,169	09-1996	Namba et al.	704/9
*	B	US-5,734,889	03-1998	Yamaguchi, Tomoharu	707/4
*	C	US-5,960,384	09-1999	Brash, Douglas E.	704/9
*	D	US-6,581,068	06-2003	Bensoussan et al.	707/104.1
*	E	US-6,947,923	09-2005	Cha et al.	707/3
*	F	US-2002/0107844	08-2002	Cha et al.	707/3
*	G	US-2003/0074181	04-2003	Gharavy, Shari	704/1
*	H	US-2004/0221235	11-2004	Marchisio et al.	715/534
*	I	US-2005/0043940	02-2005	Elder, Marvin	704/009
*	J	US-2005/0216421	09-2005	Barry et al.	705/064
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.